

Notice of References Cited

Application/Control No.

10/822,309

Applicant(s)/Patent Under
Reexamination
LEE ET AL.

Examiner

Venkatesh Haliyur

Art Unit

2616

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,124,163	10-2006	Geofroy et al.	709/203
*	B	US-7,234,126	06-2007	Catthoor et al.	716/18
*	C	US-6,775,267	08-2004	Kung et al.	370/352
*	D	US-6,826,173	11-2004	Kung et al.	370/352
*	E	US-7,110,416	09-2006	Selin, Jari	370/433
*	F	US-6,888,821	05-2005	Rasanen et al.	370/352
*	G	US-6,879,581	04-2005	Leung, Nikolai K. N.	370/352
*	H	US-2004/0057446	03-2004	Varsa et al.	370/412
*	I	US-2002/0141740	10-2002	Matsui, Yoshinori	386/111
*	J	US-5,565,924	10-1996	Haskell et al.	348/423.1
*	K	US-2003/0061369	03-2003	Aksu et al.	709/231
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.